



LIST OF PUBLICATIONS CITED BY APPLICANT	<u>Atty. Docket No.</u> SEL 213	<u>Serial No.</u> 09/685,698
	<u>Applicant</u> Shunpei YAMAZAKI et al	
	<u>Filing Date</u> October 10, 2000	<u>Group</u> 2813

U. S. PATENT DOCUMENTS

*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB-CLASS	FILING DATE
<i>SL</i> <i>RL</i>	5,189,405 5,920,080	02/23/93 07/06/99	Yamashita et al Jones	340 257	781 40	12/23/91 05/08/98

FOREIGN PATENT DOCUMENTS

	DOCUMENT NUMBER	DATE	APPLICANT	English Abstract	English Trans.	FILING DATE

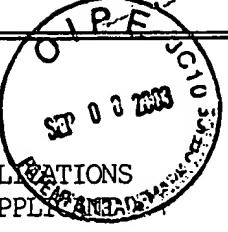
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(Include name of author (in CAPITAL LETTERS), title of article or item (book, magazine, journal, serial, symposium, catalog, etc.) date, pages(s), volume-issue number(s), publisher, city and/or country where published).

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EXAMINER:	<i>Naresha Schley</i>	DATE CONSIDERED:
		<i>4/26/06</i>

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U.S. PATENT DOCUMENTS

*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB-CLASS	FILING DATE
<i>SL</i>	4,737,803	04/12/88	Fujimura et al	346	140	07/07/87
<i>SL</i>	5,985,356	11/16/99	Schultz et al	427	8	10/18/94
<i>SL</i>	US 2002/0009536 A1	01/24/02	Iguchi et al	427	10	12/16/97
<i>SL</i>	US 2002/0041926 A1	04/11/02	Miyashita et al	427	66	10/24/01

FOREIGN PATENT DOCUMENTS

	DOCUMENT NUMBER	DATE	NAME	English Abstract	English Trans.	FILING DATE
<i>SL</i>	WO 98/24271	06/04/98	Seiko Epson Corp.	X		11/25/97
<i>SL</i>	WO 98/27579	06/25/98	Stella Chemifa Kabushiki Kaisha	X		12/15/97

OTHER PRIOR ART - NON-PATENT LITERATURE DOCUMENTS (Including Author, Title, Date, Pertinent Pages)

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EXAMINER:	<i>hanna Schultz</i>	DATE CONSIDERED:	<i>4/26/06</i>
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